Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/775,532	HAHN ET AL.		
Examiner	Art Unit		
Randolph Chu	2624		

SEARCHED					
Class	Subclass	Date	Examiner		
382	300	4/25/2007	RIC		
382	236	4/25/2007	RIC		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	4/25/2007	RIC
Inventor Name Search	4/25/2007	RIC
Consult with Wenpeng Chen	12/21/2006	RIC
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